

# SEMITRANS<sup>®</sup> 3

## SPT IGBT Module

#### SKM 200GB128D

## Features

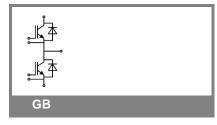
- Homogeneous Si
- SPT = Soft-Punch-Through technology
- V<sub>CEsat</sub> with positive temperature coefficient
- High short circuit capability, self limiting to 6 x l<sub>c</sub>

## **Typical Applications**

- AC inverter drives
- UPS
- Electronic welders f<sub>sw</sub> up to 20kHz

 $T_c = 25 \text{ °C}$ , unless otherwise specified **Absolute Maximum Ratings** Symbol Conditions Values Units IGBT T<sub>i</sub> = 150 °C V V<sub>CES</sub> 1200 T<sub>c</sub> = 25 °C T<sub>i</sub> = 150 °C 300 А  $I_{C}$ T<sub>c</sub> = 80 °C 220 А 300 А  $I_{CRM} = 2 x I_{Cnom}$ I<sub>CRM</sub> ± 20 V V<sub>GES</sub>  $V_{CC} = 600 \text{ V}; \text{ } V_{GE} \leq 20 \text{ V}; \quad \text{ } T_j = 125 \text{ }^\circ\text{C}$ 10 μs t<sub>psc</sub> VCES < 1200 V Inverse Diode T<sub>i</sub> = 150 °C T<sub>case</sub> = 25 °C 190 А I<sub>F</sub> T<sub>case</sub> = 80 °C 130 А  $I_{FRM} = 2x I_{Fnom}$ 300 А I<sub>FRM</sub> t<sub>p</sub> = 10 ms; sin. T<sub>i</sub> = 150 °C 1440 А  $I_{FSM}$ Module 500 А I<sub>t(RMS)</sub> T<sub>vj</sub> - 40... + 150 °C - 40... + 125 °C T<sub>stg</sub>  $V_{isol}$ AC, 1 min. 4000 V

| Characteristics T <sub>c</sub> = |   |  | 25 °C, unless otherwise specified |      |       |       |
|----------------------------------|---|--|-----------------------------------|------|-------|-------|
| Symbol                           | Conditions  |  | min.                              | typ. | max.  | Units |
| IGBT                             |   |  |                                   |      |       |       |
| V <sub>GE(th)</sub>              | $V_{GE} = V_{CE}, I_{C} = 6 \text{ mA}$           |  | 4,5                               | 5,5  | 6,45  | V     |
| I <sub>CES</sub>                 | $V_{GE}$ = 0 V, $V_{CE}$ = $V_{CES}$              | T <sub>j</sub> = 25 °C                     |                                   | 0,2  | 0,6   | mA    |
| V <sub>CE0</sub>                 |   | T <sub>j</sub> = 25 °C                     |                                   | 1    | 1,15  | V     |
|                                  |   | T <sub>j</sub> = 125 °C                    |                                   | 0,9  | 1,05  | V     |
| r <sub>CE</sub>                  | V <sub>GE</sub> = 15 V                            | T <sub>j</sub> = 25°C                      |                                   | 6    | 8     | mΩ    |
|                                  |   | T <sub>j</sub> = 125°C                     |                                   | 8    | 10    | mΩ    |
| V <sub>CE(sat)</sub>             | I <sub>Cnom</sub> = 150 A, V <sub>GE</sub> = 15 V |  |                                   | 1,9  | 2,35  | V     |
|                                  |   | T <sub>j</sub> = 125°C <sub>chiplev.</sub> |                                   | 2,1  | 2,55  | V     |
| C <sub>ies</sub>                 |   |  |                                   | 13   |       | nF    |
| C <sub>oes</sub>                 | $V_{CE}$ = 25, $V_{GE}$ = 0 V                     | f = 1 MHz                                  |                                   | 2    |       | nF    |
| C <sub>res</sub>                 |   |  |                                   | 2    |       | nF    |
| Q <sub>G</sub>                   | V <sub>GE</sub> = -8V- +20V                       |  |                                   | 1700 |       | nC    |
| R <sub>Gint</sub>                | T <sub>j</sub> = 25 °C                            |  |                                   | 2,5  |       | Ω     |
| t <sub>d(on)</sub>               |   |  |                                   | 125  |       | ns    |
| t <sub>r</sub>                   | $R_{Gon} = 7 \Omega$                              | V <sub>CC</sub> = 600V                     |                                   | 50   |       | ns    |
| E <sub>on</sub>                  | di/dt = 4800 A/µs                                 | I <sub>C</sub> = 150A                      |                                   | 18   |       | mJ    |
| t <sub>d(off)</sub>              | $R_{Goff} = 7 \Omega$                             | T <sub>j</sub> = 125 °C                    |                                   | 620  |       | ns    |
| t <sub>f</sub>                   |   | V <sub>GE</sub> = ±15V                     |                                   | 55   |       | ns    |
| E <sub>off</sub>                 |   | L <sub>s</sub> = 20 nH                     |                                   | 15   |       | mJ    |
| R <sub>th(j-c)</sub>             | per IGBT  |  |                                   |      | 0,095 | K/W   |





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| Characteristics       |  |   |      |      |       |       |  |
|-----------------------|--|---|------|------|-------|-------|--|
| Symbol                | Conditions                                       |   | min. | typ. | max.  | Units |  |
| Inverse Diode         |  |   |      |      |       |       |  |
| $V_F = V_{EC}$        | I <sub>Fnom</sub> = 150 A; V <sub>GE</sub> = 0 V |   |      | 2    | 2,5   | V     |  |
|                       |  | T <sub>j</sub> = 125 °C <sub>chiplev.</sub> |      | 1,8  |       | V     |  |
| V <sub>F0</sub>       |  | T <sub>j</sub> = 25 °C                      |      | 1,1  | 1,2   | V     |  |
| r <sub>F</sub>        |  | T <sub>j</sub> = 25 °C                      |      | 6    | 7,8   | mΩ    |  |
| I <sub>RRM</sub>      | I <sub>F</sub> = 150 A                           | T <sub>j</sub> = 125 °C                     |      | 190  |       | А     |  |
| Q <sub>rr</sub>       | di/dt = 4800 A/µs                                | -   |      | 24   |       | μC    |  |
| E <sub>rr</sub>       | $V_{GE}$ = -15 V; $V_{CC}$ = 600 V               |   |      | 8    |       | mJ    |  |
| R <sub>th(j-c)D</sub> | per diode  |   |      |      | 0,25  | K/W   |  |
| Module                |  |   |      |      |       |       |  |
| L <sub>CE</sub>       |  |   |      | 15   | 20    | nH    |  |
| R <sub>CC'+EE'</sub>  | res., terminal-chip                              | T <sub>case</sub> = 25 °C                   |      | 0,35 |       | mΩ    |  |
|                       |  | T <sub>case</sub> = 125 °C                  |      | 0,5  |       | mΩ    |  |
| R <sub>th(c-s)</sub>  | per module                                       |   |      |      | 0,038 | K/W   |  |
| M <sub>s</sub>        | to heat sink M6                                  |   | 3    |      | 5     | Nm    |  |
| M <sub>t</sub>        | to terminals M6                                  |   | 2,5  |      | 5     | Nm    |  |
| w                     |  |   |      |      | 325   | g     |  |

Features

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## **Typical Applications**

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This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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| Z <sub>th</sub>             |            |        |       |  |  |  |  |  |
|-----------------------------|------------|--------|-------|--|--|--|--|--|
| Symbol                      | Conditions | Values | Units |  |  |  |  |  |
|                             |            |        |       |  |  |  |  |  |
| Z<br>Ri<br>Ri               | i = 1      | 65     | mk/W  |  |  |  |  |  |
| R <sub>i</sub>              | i = 2      | 22     | mk/W  |  |  |  |  |  |
| R <sub>i</sub>              | i = 3      | 6,8    | mk/W  |  |  |  |  |  |
| R <sub>i</sub>              | i = 4      | 1,2    | mk/W  |  |  |  |  |  |
| tau <sub>i</sub>            | i = 1      | 0,0744 | S     |  |  |  |  |  |
| tau <sub>i</sub>            | i = 2      | 0,0078 | S     |  |  |  |  |  |
| taui                        | i = 3      | 0,0016 | S     |  |  |  |  |  |
| tau <sub>i</sub>            | i = 4      | 0,0002 | s     |  |  |  |  |  |
| Z<br><sub>Ri</sub> th(j-c)D | Z          |        |       |  |  |  |  |  |
| R <sub>i</sub>              | i = 1      | 155    | mk/W  |  |  |  |  |  |
| R <sub>i</sub>              | i = 2      | 71     | mk/W  |  |  |  |  |  |
| R <sub>i</sub>              | i = 3      | 21     | mk/W  |  |  |  |  |  |
| R <sub>i</sub>              | i = 4      | 3      | mk/W  |  |  |  |  |  |
| tau                         | i = 1      | 0,0716 | S     |  |  |  |  |  |
| tau <sub>i</sub>            | i = 2      | 0,0056 | s     |  |  |  |  |  |
| taui                        | i = 3      | 0,0042 | s     |  |  |  |  |  |
| tau <sub>i</sub>            | i = 4      | 0,0002 | s     |  |  |  |  |  |

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